

N-Channel 30-V (D-S) MOSFET

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PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
30	0.014 at V _{GS} = 10 V	11	18 nC		
30	0.016 at $V_{GS} = 4.5 \text{ V}$	9	10110		

FEATURES

- DT-Trench Power MOSFET
- Optimized for High-Side Synchronous Rectifier Operation

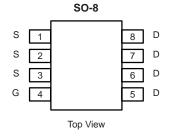


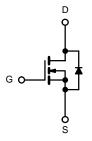
100 % UIS Tested



APPLICATIONS

- Notebook CPU Core
 - High-Side Switch





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S T _A = 25 °C, unles	s otherwise no	oted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	V
	T _C = 25 °C		11	А
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I-	9	
Continuous Diam Current (1) = 130 °C)	T _A = 25 °C	- I _D	7 ^{b, c}	
	T _A = 70 °C		5 ^{b, c}	
Pulsed Drain Current		I _{DM}	44	
Continuous Source-Drain Diode Current	T _C = 25 °C	- I _S	11	
	T _A = 25 °C		4.5 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	25	
Avalanche Energy	L = 0.111111	E _{AS}	79	mJ
	T _C = 25 °C		3	
Maximum Dawar Dissipation	$T_C = 70 ^{\circ}C$	P _D	1.9	w
Maximum Power Dissipation	T _A = 25 °C	гD	1.5 ^{b, c}	VV
	T _A = 70 °C		0.8 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	25	44	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	22	28	C/VV	

Notes:

- a. Base on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 °C/W.

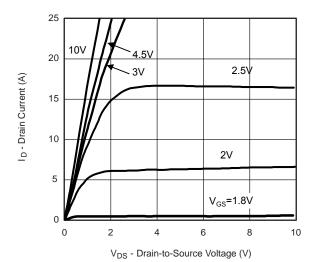


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				<u> </u>			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250 WA		28		\//90	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = 250 μA		- 6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Valta va Busia Oamaat		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	1		1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
	_	V _{GS} = 10 V, I _D = 8 A		0.014	0.017	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$		0.016	0.020		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 8 A		42		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1965		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		356			
Reverse Transfer Capacitance	C _{rss}			98			
		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 8 A		23			
Total Gate Charge	Q_g			18			
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		2.2		nC	
Gate-Drain Charge	Q _{gd}			4.3		1	
Gate Resistance	R_g	f = 1 MHz		0.9		Ω	
Turn-On Delay Time	t _{d(on)}			6			
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		5		1	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		32		1	
Fall Time	t _f			7		1	
Turn-On Delay Time	t _{d(on)}			4		ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		5		1	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 5$ A, V_{GEN} = 10 V, R_g = 1 Ω		30		1	
Fall Time	t _f			6		1	
Drain-Source Body Diode Characterist	ics			·!	•		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			11		
Pulse Diode Forward Current ^a	I _{SM}				44	A	
Body Diode Voltage	V_{SD}	I _S = 8 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			15		ns	
Body Diode Reverse Recovery Charge	Q _{rr}			19		nC	
Reverse Recovery Fall Time	t _a	$I_F = 8 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		8		ns	
Reverse Recovery Rise Time	t _b			7	+		

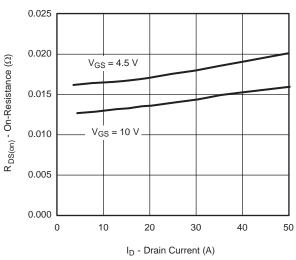
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

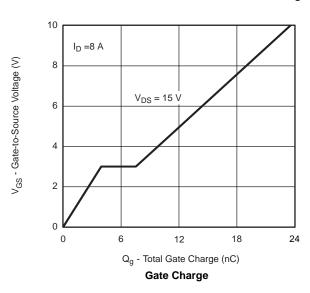


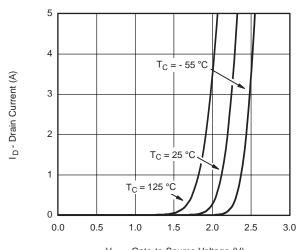


Output Characteristics

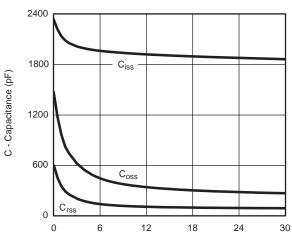


On-Resistance vs. Drain Current and Gate Voltage

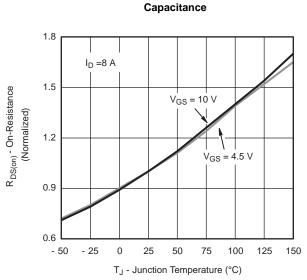




V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

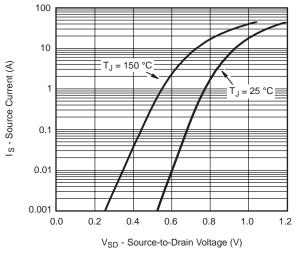


V_{DS} - Drain-to-Source Voltage (V)

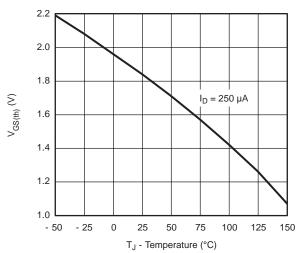


On-Resistance vs. Junction Temperature

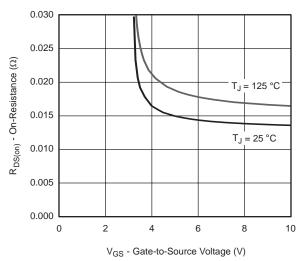




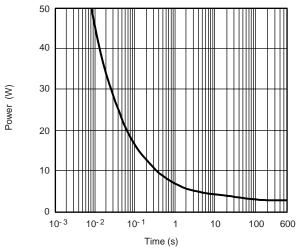
Source-Drain Diode Forward Voltage



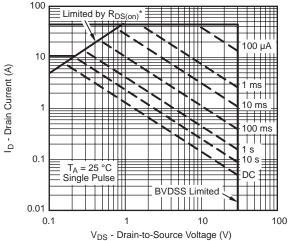
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



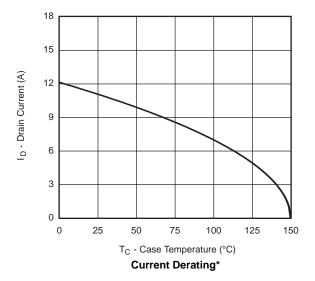
Single Pulse Power, Junction-to-Ambient

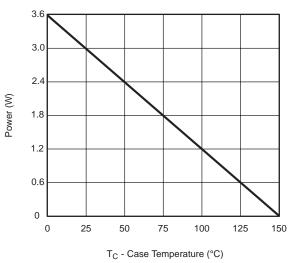


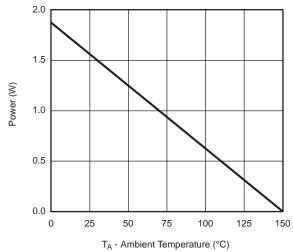
* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area, Junction-to-Ambient







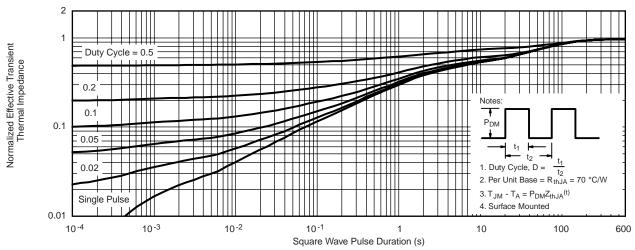


Power Derating, Junction-to-Foot

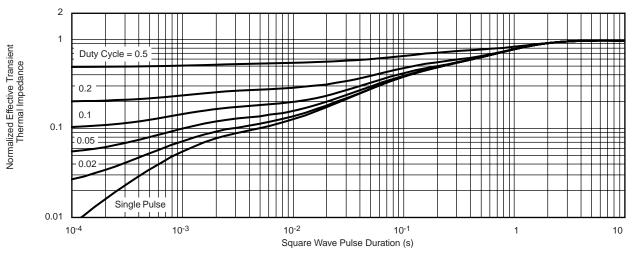
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

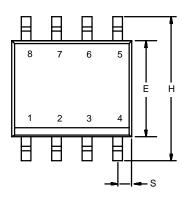


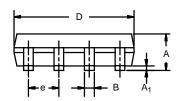
Normalized Thermal Transient Impedance, Junction-to-Foot

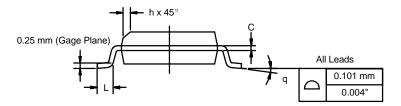




SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







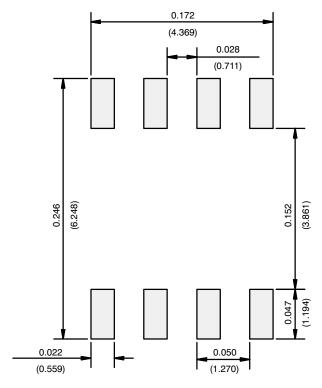
	MILLIM	IETERS	INC	HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C 06527 Pay 1 11 San 06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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